Machine learning: lecture 12

Tommi S. Jaakkola MIT CSAIL tommi@csail.mit.edu

Topics

- Complexity and model selection
 - Finite case
 - VC dimension
 - structural risk minimization

Why care about "complexity"?



 We need a quantitative measure of complexity in order to be able to relate the training error (which we can observe) and the test error (that we'd like to optimize)

Simple case: finite number of classifiers

- Suppose we consider only a finite number of classifiers, $h_1(\mathbf{x}), \ldots, h_m(\mathbf{x}).$
- How does the number of classifiers m affect the difference between training and test errors?

Simple case: finite number of classifiers

- Suppose we consider only a finite number of classifiers, $h_1(\mathbf{x}), \ldots, h_m(\mathbf{x}).$
- How does the number of classifiers m affect the difference between training and test errors?

Let's start by defining

$$\hat{\mathcal{E}}_{n}(i) = \frac{1}{n} \sum_{t=1}^{n} \underbrace{\mathsf{Loss}(y_{t}, h_{i}(\mathbf{x}_{t}))}_{t=1} = \text{empirical error of } h_{i}(\mathbf{x})$$
$$\mathcal{E}(i) = E_{(\mathbf{x}, y) \sim P} \{ \mathsf{Loss}(y, h_{i}(\mathbf{x})) \} = \text{expected error of } h_{i}(\mathbf{x})$$

$$\hat{\mathcal{E}}_{n}(i) = \frac{1}{n} \sum_{t=1}^{n} \text{Loss}(y_{t}, h_{i}(\mathbf{x}_{t})) = \text{empirical error of } h_{i}(\mathbf{x})$$
$$\mathcal{E}(i) = E_{(\mathbf{x}, y) \sim P} \{ \text{Loss}(y, h_{i}(\mathbf{x})) \} = \text{expected error of } h_{i}(\mathbf{x})$$

• If we choose the classifier that minimizes the training error, $\hat{i}_n = \arg\min_i \hat{\mathcal{E}}_n(i)$, then

Training error
$$= \hat{\mathcal{E}}_n(\hat{i}_n)$$

Test error $= \mathcal{E}(\hat{i}_n)$

$$\hat{\mathcal{E}}_{n}(i) = \frac{1}{n} \sum_{t=1}^{n} \text{Loss}(y_{t}, h_{i}(\mathbf{x}_{t})) = \text{empirical error of } h_{i}(\mathbf{x})$$
$$\mathcal{E}(i) = E_{(\mathbf{x}, y) \sim P} \{ \text{Loss}(y, h_{i}(\mathbf{x})) \} = \text{expected error of } h_{i}(\mathbf{x})$$

• If we choose the classifier that minimizes the training error, $\hat{i}_n = \arg\min_i \hat{\mathcal{E}}_n(i)$, then

Training error
$$= \hat{\mathcal{E}}_n(\hat{i}_n)$$

Test error $= \mathcal{E}(\hat{i}_n)$

• The training and test errors are necessarily close if

$$|\hat{\mathcal{E}}_n(i) - \mathcal{E}(i)| \le \epsilon$$
, for all $i = 1, \dots, m$

• We'd like to evaluate the probability that the training error deviates more than ϵ from the corresponding test error:

$$P\left(\exists i: |\hat{\mathcal{E}}_n(i) - \mathcal{E}(i)| > \epsilon\right)$$

where the probability is over the choice of the training set.

• We'd like to evaluate the probability that the training error deviates more than ϵ from the corresponding test error:

$$P\left(\exists i: |\hat{\mathcal{E}}_n(i) - \mathcal{E}(i)| > \epsilon\right)$$

where the probability is over the choice of the training set. By using the fact that $P(A \text{ or } B) \leq P(A) + P(B)$ we get

$$P\left(\exists i: |\hat{\mathcal{E}}_n(i) - \mathcal{E}(i)| > \epsilon\right) \leq \sum_{i=1}^m P\left(|\hat{\mathcal{E}}_n(i) - \mathcal{E}(i)| > \epsilon\right)$$

• We'd like to evaluate the probability that the training error deviates more than ϵ from the corresponding test error:

$$P\left(\exists i: |\hat{\mathcal{E}}_n(i) - \mathcal{E}(i)| > \epsilon\right)$$

where the probability is over the choice of the training set. By using the fact that $P(A \text{ or } B) \leq P(A) + P(B)$ we get

$$P\left(\exists i: |\hat{\mathcal{E}}_{n}(i) - \mathcal{E}(i)| > \epsilon\right) \leq \sum_{i=1}^{m} P\left(|\hat{\mathcal{E}}_{n}(i) - \mathcal{E}(i)| > \epsilon\right)$$
$$\leq \sum_{i=1}^{m} 2\exp(-2n\epsilon^{2}) \quad \text{(Chernoff)}$$

• We'd like to evaluate the probability that the training error deviates more than ϵ from the corresponding test error:

$$P\left(\exists i: |\hat{\mathcal{E}}_n(i) - \mathcal{E}(i)| > \epsilon\right)$$

where the probability is over the choice of the training set. By using the fact that $P(A \text{ or } B) \leq P(A) + P(B)$ we get

$$P\left(\exists i: |\hat{\mathcal{E}}_{n}(i) - \mathcal{E}(i)| > \epsilon\right) \leq \sum_{i=1}^{m} P\left(|\hat{\mathcal{E}}_{n}(i) - \mathcal{E}(i)| > \epsilon\right)$$
$$\leq \sum_{i=1}^{m} 2\exp(-2n\epsilon^{2}) \quad \text{(Chernoff)}$$
$$= m \cdot 2\exp(-2n\epsilon^{2})$$

• We'd like to evaluate the probability that the training error deviates more than ϵ from the corresponding test error:

$$P\left(\exists i: |\hat{\mathcal{E}}_n(i) - \mathcal{E}(i)| > \epsilon\right)$$

where the probability is over the choice of the training set. By using the fact that $P(A \text{ or } B) \leq P(A) + P(B)$ we get

$$P\left(\exists i: |\hat{\mathcal{E}}_{n}(i) - \mathcal{E}(i)| > \epsilon\right) \leq \sum_{i=1}^{m} P\left(|\hat{\mathcal{E}}_{n}(i) - \mathcal{E}(i)| > \epsilon\right)$$
$$\leq \sum_{i=1}^{m} 2\exp(-2n\epsilon^{2}) \quad \text{(Chernoff)}$$
$$= m \cdot 2\exp(-2n\epsilon^{2}) = \delta$$

where $(1 - \delta)$ is our "confidence" that the errors are close.

• We can restate our result in terms of a bound on the expected error of any classifier in our set.

$$m \cdot 2 \exp(-2n\epsilon^2) = \delta$$
, or $\epsilon = \sqrt{\frac{1}{2n}}(\log(2m) + \log(1/\delta))$

Theorem: With probability at least $1 - \delta$ over the choice of the training set, for all $i = 1, \ldots, m$

$$\mathcal{E}(i) \le \hat{\mathcal{E}}_n(i) + \epsilon(n, m, \delta)$$

where $\epsilon = \epsilon(n, m, \delta)$ given above is a "complexity penalty".

• We can restate our result in terms of a bound on the expected error of any classifier in our set.

$$m \cdot 2 \exp(-2n\epsilon^2) = \delta$$
, or $\epsilon = \sqrt{\frac{1}{2n}}(\log(2m) + \log(1/\delta))$

Theorem: With probability at least $1 - \delta$ over the choice of the training set, for all i = 1, ..., m

$$\mathcal{E}(i) \le \hat{\mathcal{E}}_n(i) + \epsilon(n, m, \delta)$$

where $\epsilon = \epsilon(n, m, \delta)$ given above is a "complexity penalty".

- The complexity penalty
 - is an increasing function of \boldsymbol{m}
 - increases as δ decreases
 - decreases as a function of \boldsymbol{n}

Measures of complexity

- "Complexity" is a measure of a set of classifiers, not any specific (fixed) classifier
- Many possible measures
 - degrees of freedom
 - description length
 - Vapnik-Chervonenkis (VC) dimension

etc.

VC-dimension: preliminaries

• A set of classifiers F:

For example, this could be the set of all possible linear separators, where $h \in F$ means that

$$h(\mathbf{x}) = \operatorname{sign}\left(w_0 + \mathbf{w}^T \mathbf{x}\right)$$

for some values of the parameters \mathbf{w}, w_0 .

VC-dimension: preliminaries

• Complexity: how many different ways can we label n training points $\{\mathbf{x}_1, \ldots, \mathbf{x}_n\}$ with classifiers $h \in F$?

In other words, how many distinct binary vectors

$$[h(\mathbf{x}_1) h(\mathbf{x}_2) \dots h(\mathbf{x}_n)]$$

do we get by trying each $h \in F$ in turn?

$$\begin{bmatrix} -1 & 1 & \dots & 1 \end{bmatrix} h_1 \\ \begin{bmatrix} 1 & -1 & \dots & 1 \end{bmatrix} h_2$$

. . .

VC-dimension: shattering

• A set of classifiers F shatters n points $\{\mathbf{x}_1, \dots, \mathbf{x}_n\}$ if $[h(\mathbf{x}_1) \ h(\mathbf{x}_2) \ \dots \ h(\mathbf{x}_n)], \ h \in F$

generates all 2^n distinct labelings.

 Example: linear decision boundaries shatter (any) 3 points in 2D



but not any 4 points...

VC-dimension: shattering cont'd

• We cannot shatter 4 points in 2D with linear separators For example, the following labeling



cannot be produced with any linear separator

- More generally: the set of all d-dimensional linear separators can shatter exactly d + 1 points
- **Definition:** The VC-dimension of a set of classifiers *F* is the number of points *F* can shatter

Learning and VC-dimension

• We don't really learn anything until after we have more than d_{VC} training examples



• The number of labelings that the set of classifiers can generate over n points increases sub-exponentially only after $n > d_{VC}$ (in this case $d_{VC} = 100$)

Learning and VC-dimension

• Let d_{VC} be the VC-dimension of our set of classifiers F.

Theorem: With probability at least $1 - \delta$ over the choice of the training set, for all $h \in F$

$$\mathcal{E}(h) \le \hat{\mathcal{E}}_n(h) + \epsilon(n, d_{VC}, \delta)$$

where

$$\epsilon(n, d_{VC}, \delta) = \sqrt{\frac{d_{VC}(\log(2n/d_{VC}) + 1) + \log(1/(4\delta))}{n}}$$

Complexity and margin

• The number of possible labelings of points with large margin can be dramatically less than the (basic) VC-dimension



• The set of separating hyperplaces which attain margin γ or better for examples within a sphere of radius R has VC-dimension bounded by $d_{VC}(\gamma) \leq R^2/\gamma^2$

Model selection

- We try to find the model with the best balance of complexity and the fit to the training data
- Ideally, we would select a model from a nested sequence of models of increasing complexity (VC-dimension)
 - Model 1 d_1
 - Model 2 d_2
 - Model 3 d_3

where $d_1 \leq d_2 \leq d_3 \leq \ldots$

• The model selection criterion is: find the model class that achieves the lowest upper *bound* on the expected loss

Expected error \leq Training error + Complexity penalty

Structural risk minimization cont'd

• We choose the model class F_i that minimizes the upper bound on the expected error:

$$\mathcal{E}(\hat{h}_i) \le \hat{\mathcal{E}}_n(\hat{h}_i) + \sqrt{\frac{d_i(\log(2n/d_i) + 1) + \log(1/(4\delta))}{n}}$$

where \hat{h}_i is the best classifier from F_i selected on the basis of the training set.



Example

- Models of increasing complexity
 - $\begin{array}{ll} \text{Model 1} & K(\mathbf{x}_1, \mathbf{x}_2) = (1 + (\mathbf{x}_1^T \mathbf{x}_2)) \\ \text{Model 2} & K(\mathbf{x}_1, \mathbf{x}_2) = (1 + (\mathbf{x}_1^T \mathbf{x}_2))^2 \\ \text{Model 3} & K(\mathbf{x}_1, \mathbf{x}_2) = (1 + (\mathbf{x}_1^T \mathbf{x}_2))^3 \end{array}$
- These are nested, i.e.,

. . .

. . .

$$F_1 \subseteq F_2 \subseteq F_3 \subseteq \dots$$

where F_k refers to the set of possible decision boundaries that the model k can represent.

Structural risk minimization: example



Structural risk minimization: example cont'd

• Number of training examples n = 50, confidence parameter $\delta = 0.05$.

Model	d_{VC}	Empirical fit	$\epsilon(n, d_{VC}, \delta)$
1^{st} order	3	0.06	0.5501
2^{nd} order	6	0.06	0.6999
4^{th} order	15	0.04	0.9494
8^{th} order	45	0.02	1.2849

• Structural risk minimization would select the simplest (linear) model in this case.